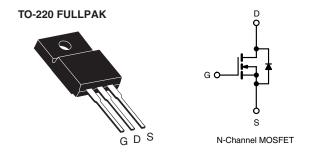


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	100			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.54		
Q _g (Max.) (nC)	8.3			
Q _{gs} (nC)	2.3			
Q _{gd} (nC)	3.8			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)



RoHS COMPLIANT

- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- · Lead (Pb)-free Available

DESCRIPTION

Third Generation Power MOSFETs from Vishay provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFI510GPbF	
Lead (1 b)-nee	SiHFI510G-E3	
SnPb	IRFI510G	
On b	SiHFI510G	

PARAMETER	SYMBOL	LIMIT	UNIT		
Gate-Source Voltage	V_{GS}	± 20	V		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 ^{\circ}C$,	4.5	А	
	V_{GS} at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I _D	3.2		
Pulsed Drain Current ^a	I _{DM}	18			
Linear Derating Factor			0.18		
Single Pulse Avalanche Energy ^b	E _{AS}	60	mJ		
Repetitive Avalanche Current ^a	I _{AR}	4.5	Α		
Repetitive Avalanche Energy ^a	E _{AR}	2.7	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	27	W	
Peak Diode Recovery dV/dtc	dV/dt	4.5	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	7	
Mounting Torque	C OO or MO corour		10	lbf ⋅ in	
	6-32 or M3 screw		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 4.4 mH, R_G = 25 Ω , I_{AS} = 4.5 A (see fig. 12).
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI510G, SiHFI510G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R_{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	=	5.5	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 1 mA	-	0.63	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	' _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20$		-	-	± 100	nA
Zero Gate Voltage Drain Current	lana	V _{DS} = 100 V, V _{GS} = 0 V		1	-	25	μΑ
Zero date voltage Drain Guirent	I _{DSS}	V _{DS} = 80 V, V	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 2.7 A^b$	1	-	0.54	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 50 \text{ V}, I_D = 2.7 \text{ A}^{b}$		1.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V}$ $V_{DS} = 25 \text{ V}$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		1	180	-	- pF
Output Capacitance	C_{oss}			ı	81	-	
Reverse Transfer Capacitance	C_{rss}			ı	15	-	
Drain to Sink Capacitance	С	f =	f = 1.0 MHz		12	-	
Total Gate Charge	Q_g			-	-	8.3	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b	-	-	2.3	
Gate-Drain Charge	Q_{gd}		see lig. 0 and 15	-	-	3.8	
Turn-On Delay Time	t _{d(on)}			1	6.9	-	
Rise Time	t _r	V_{DD} = 50 V, I_{D} = 5.6 A R_{G} = 24 Ω, R_{D} = 8.4 Ω, see fig. 10 ^b		-	16	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	15	-	
Fall Time	t _f			-	9.4	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.5	- А
Pulsed Diode Forward Current ^a	I _{SM}			ı	-	18	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 4.5 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		ı	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 5.6 \text{A}, \text{di/dt} = 100 \text{A/}\mu\text{s}^b$		ı	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.44	0.88	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	on is dor	ninated b	v Ls and	 L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

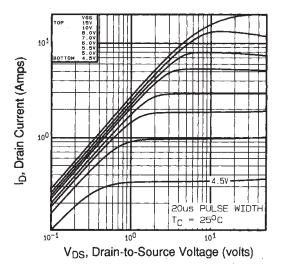


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

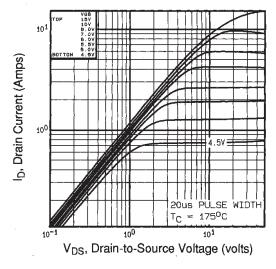


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

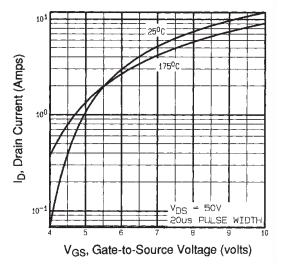


Fig. 3 - Typical Transfer Characteristics

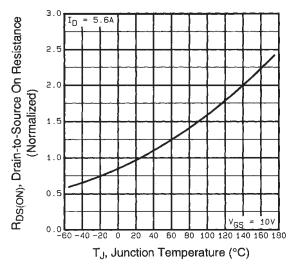


Fig. 4 - Normalized On-Resistance vs. Temperature

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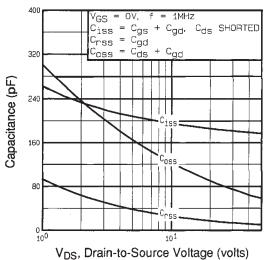


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

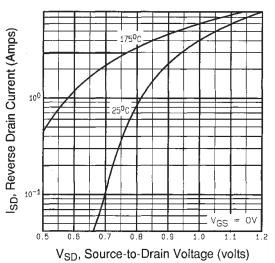


Fig. 7 - Typical Source-Drain Diode Forward Voltage

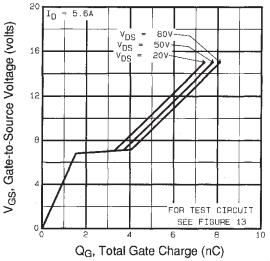


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

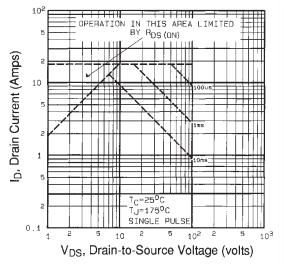


Fig. 8 - Maximum Safe Operating Area



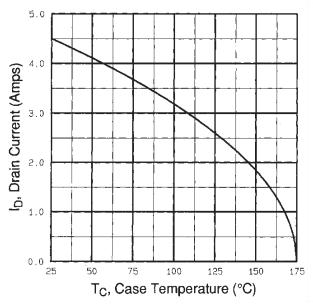


Fig. 9 - Maximum Drain Current vs. Case Temperature

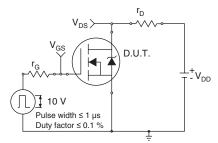


Fig. 10a - Switching Time Test Circuit

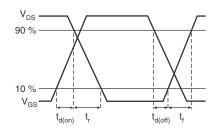


Fig. 10b - Switching Time Waveforms

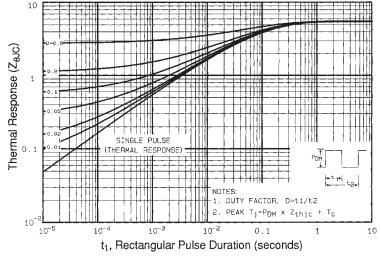


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

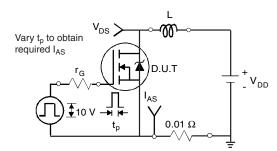


Fig. 12a - Unclamped Inductive Test Circuit

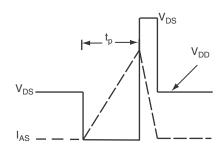


Fig. 12b - Unclamped Inductive Waveforms

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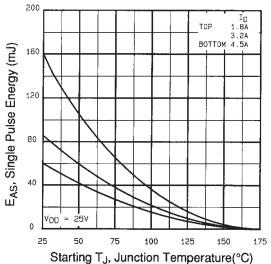


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

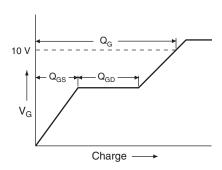


Fig. 13a - Basic Gate Charge Waveform

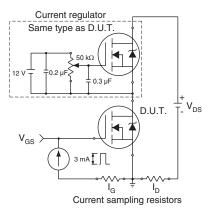
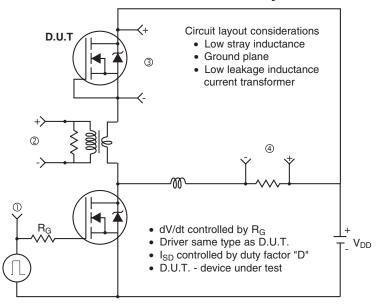


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



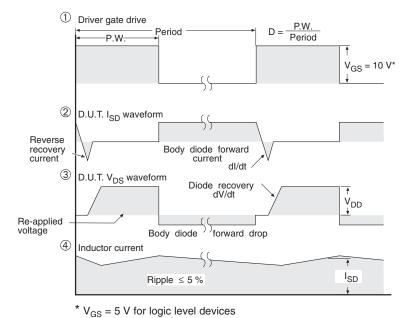


Fig. 14 - For N-Channel

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